


<b>Search Notes</b>  	<b>Application/Control No.</b>  10522720	<b>Applicant(s)/Patent Under Reexamination</b>  KAWAKAMI, TAKASHI
	<b>Examiner</b>  HENOK G HEYI	<b>Art Unit</b>  2627

### SEARCHED

Class	Subclass	Date	Examiner
369	30.03	05/02/2008	Henok Heyi
	30.05	05/02/2008	Henok Heyi
	83	05/02/2008	Henok Heyi
	84	05/02/2008	Henok Heyi
	47.12	05/02/2008	Henok Heyi
	47.13	05/02/2008	Henok Heyi

### SEARCH NOTES

Search Notes	Date	Examiner
Searched EAST and consulted Primary Tan Dinh.	05/02/2008	Henok Heyi

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner